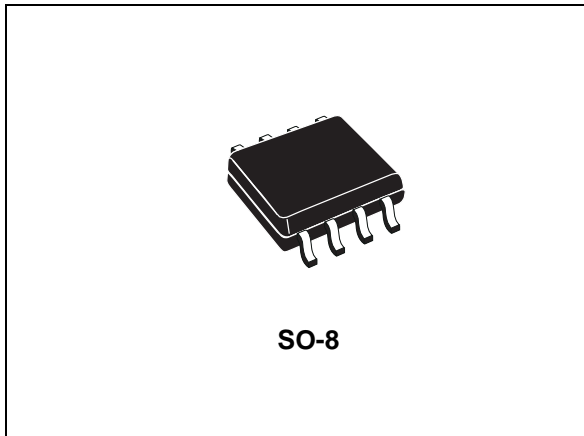


DUAL P-Channel 30 V, 0.04 Ω typ., 5 A STripFET™ VI DeepGATE™ Power MOSFET in a SO-8 package

Datasheet - preliminary data



Features

Order code	V_{DS}	$R_{DS(on)}$ max	I_D
STS5DP3LLH6	30 V	0.06 Ω at 10 V	5 A

- $R_{DS(on)}$ * Qg industry benchmark
- Extremely low on-resistance $R_{DS(on)}$
- High avalanche ruggedness
- Low gate drive power losses

Applications

- Switching applications

Description

This device is a DUAL P-channel Power MOSFET developed using the 6th generation of STripFET™ DeepGATE™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest $R_{DS(on)}$ in all packages.

Figure 1. Internal schematic diagram

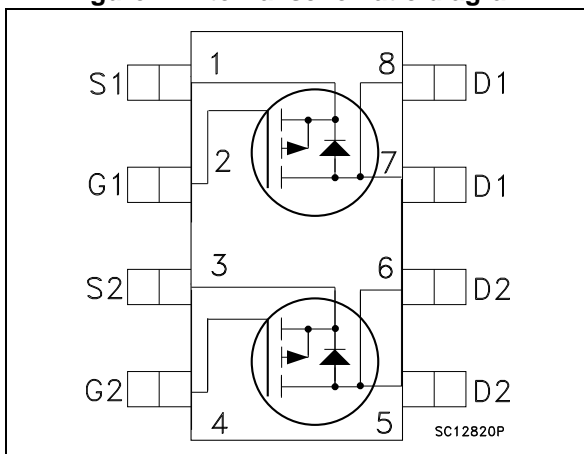


Table 1. Device summary

Order code	Marking	Package	Packaging
STS5DP3LLH6	5K3L	SO-8	Tape and reel

Note: For the P-channel MOSFET actual polarity of voltages and current has to be reversed.

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	30	V
V_{GS}	Gate-source voltage	± 20	V
I_D	Drain current (continuous) at $T_{pcb} = 25\text{ }^\circ\text{C}$	5	A
I_D	Drain current (continuous) at $T_{pcb} = 100\text{ }^\circ\text{C}$	3.2	A
$I_{DM}^{(1)(2)}$	Drain current (pulsed)	20	A
P_{TOT}	Total dissipation at $T_{pcb} = 25\text{ }^\circ\text{C}$	2.7	W
T_J	Operating junction temperature	150	$^\circ\text{C}$
T_{stg}	Storage temperature	-55 to 150	$^\circ\text{C}$

1. This value is rated according to $R_{thj-pcb}$
2. Pulse width limited by safe operating area

Table 3. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-amb}^{(1)}$	Thermal resistance junction-amb	47	$^\circ\text{C/W}$

1. When mounted on 1 inch² FR-4 board, 2 oz. Cu., $t \leq 10$ sec

Note: *For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.*

2 Electrical characteristics

($T_{CASE} = 25\text{ °C}$ unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage ($V_{GS} = 0$)	$I_D = 250\ \mu\text{A}$	30			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = 30\ \text{V}$, $V_{DS} = 30\ \text{V}$, $T_J = 125\text{ °C}$			1	μA
I_{GSS}	Gate body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 20\ \text{V}$			100	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$				V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\ \text{V}$, $I_D = 2.5\ \text{A}$ $V_{GS} = 4.5\ \text{V}$, $I_D = 2.5\ \text{A}$		0.04 0.07	0.06 0.09	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
C_{iss}	Input capacitance	$V_{DS} = 24\ \text{V}$, $f = 1\ \text{MHz}$ $V_{GS} = 0$	-	690	-	pF
C_{oss}	Output capacitance		-	120	-	
C_{rss}	Reverse transfer capacitance		-	60	-	
Q_g	Total gate charge	$V_{DD} = 24\ \text{V}$, $I_D = 5\ \text{A}$ $V_{GS} = 4.5\ \text{V}$	-	8	-	nC
Q_{gs}	Gate-source charge		-	TBD	-	
Q_{gd}	Gate-drain charge		-	TBD	-	

Table 6. Switching times

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 24\ \text{V}$, $I_D = 5\ \text{A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 10\ \text{V}$	-	TBD	-	ns
t_r	Rise time		-	TBD	-	
$t_{d(off)}$	Turn-off delay time		-	TBD	-	
t_f	Fall time		-	TBD	-	

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
I_{SD}	Source-drain current		-	-	5	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-	-	20	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 5 \text{ A}$, $V_{GS} = 0$	-	-	TBD	V
t_{rr}	Reverse recovery time	$I_{SD} = 5 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$, $V_{DD} = 16 \text{ V}$, $T_J = 150 \text{ }^\circ\text{C}$	-	-	TBD	ns
Q_{rr}	Reverse recovery charge		-	-	TBD	nC
I_{RRM}	Reverse recovery current		-	-	TBD	A

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300 μs , duty cycle 1.5%

Note: For the P-channel MOSFET the actual polarity of the voltages and the current must be reversed.

3 Test circuits

Figure 2. Switching times test circuit for resistive load

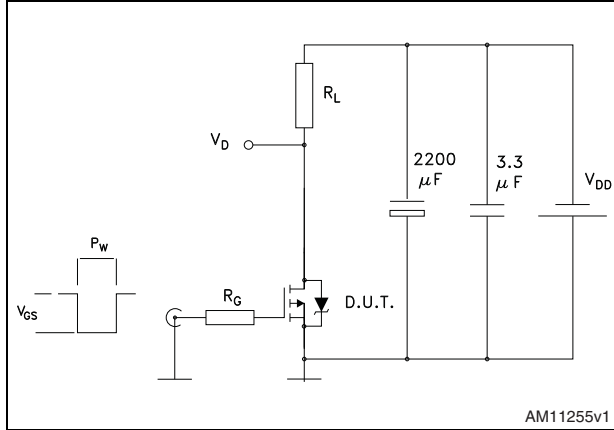


Figure 3. Gate charge test circuit

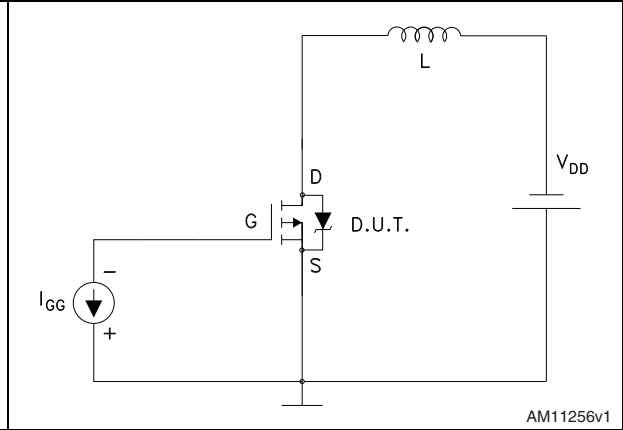
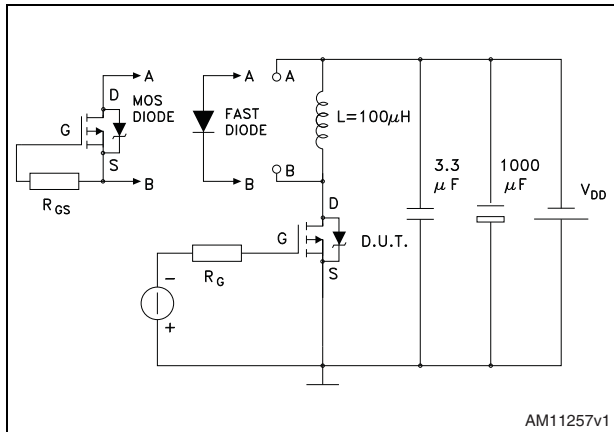


Figure 4. Test circuit for inductive load switching and diode recovery times



4 Package mechanical data

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Figure 5. SO-8 drawings

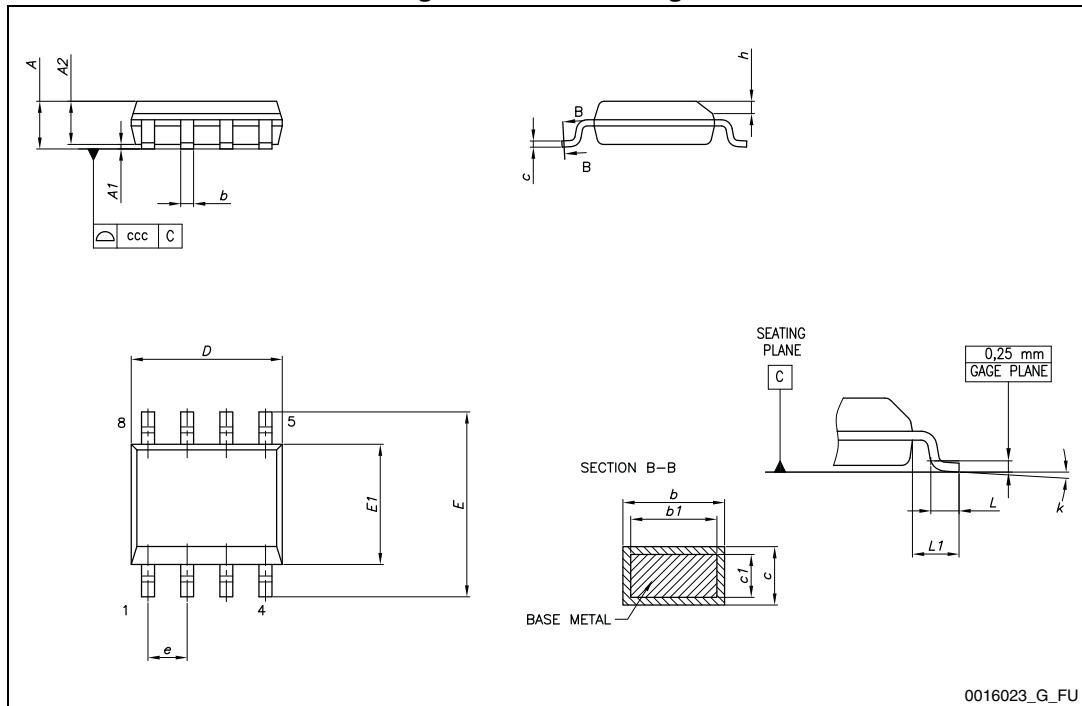
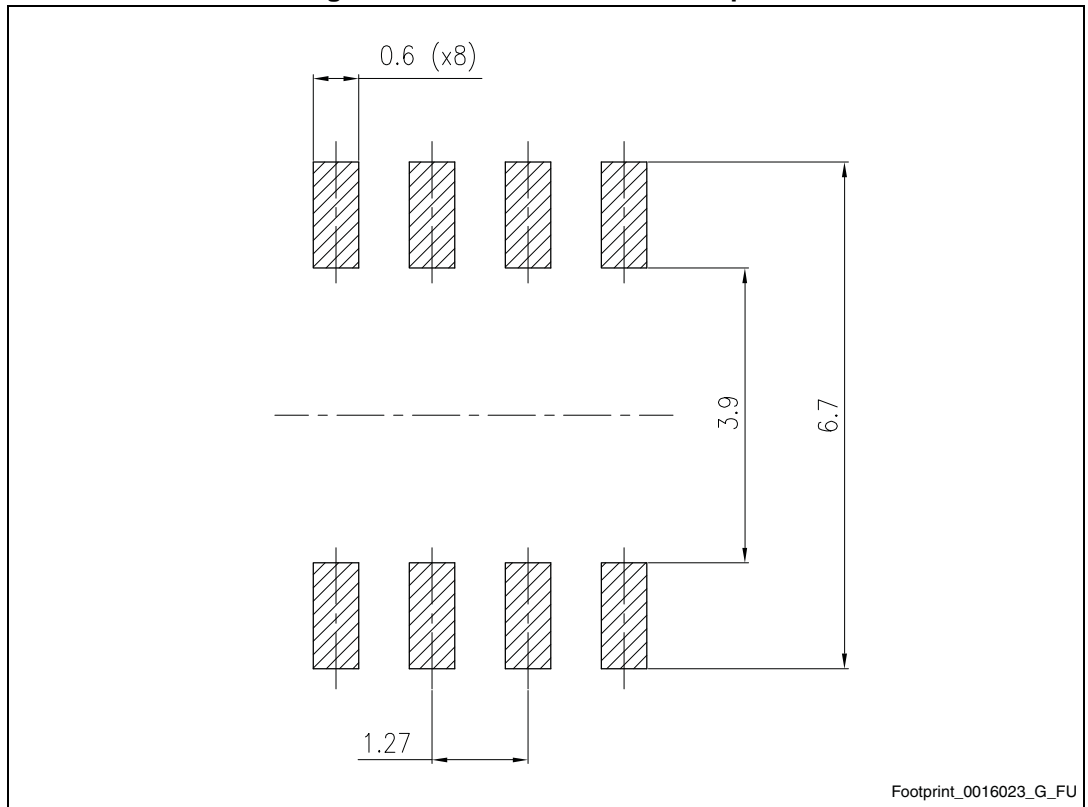


Table 8. SO-8 mechanical data

Dim	mm		
	Min.	Typ.	Max.
A			1.75
A1	0.10		0.25
A2	1.25		
b	0.31		0.51
b1	0.28		0.48
c	0.10		0.25
c1	0.10		0.23
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e		1.27	
h	0.25		0.50
L	0.40		1.27
L1		1.04	
L2		0.25	
k	0°		8°
ccc			0.10

Figure 6. SO-8 recommended footprint



5 Packaging mechanical data

Figure 7. SO-8 tape and reel dimensions

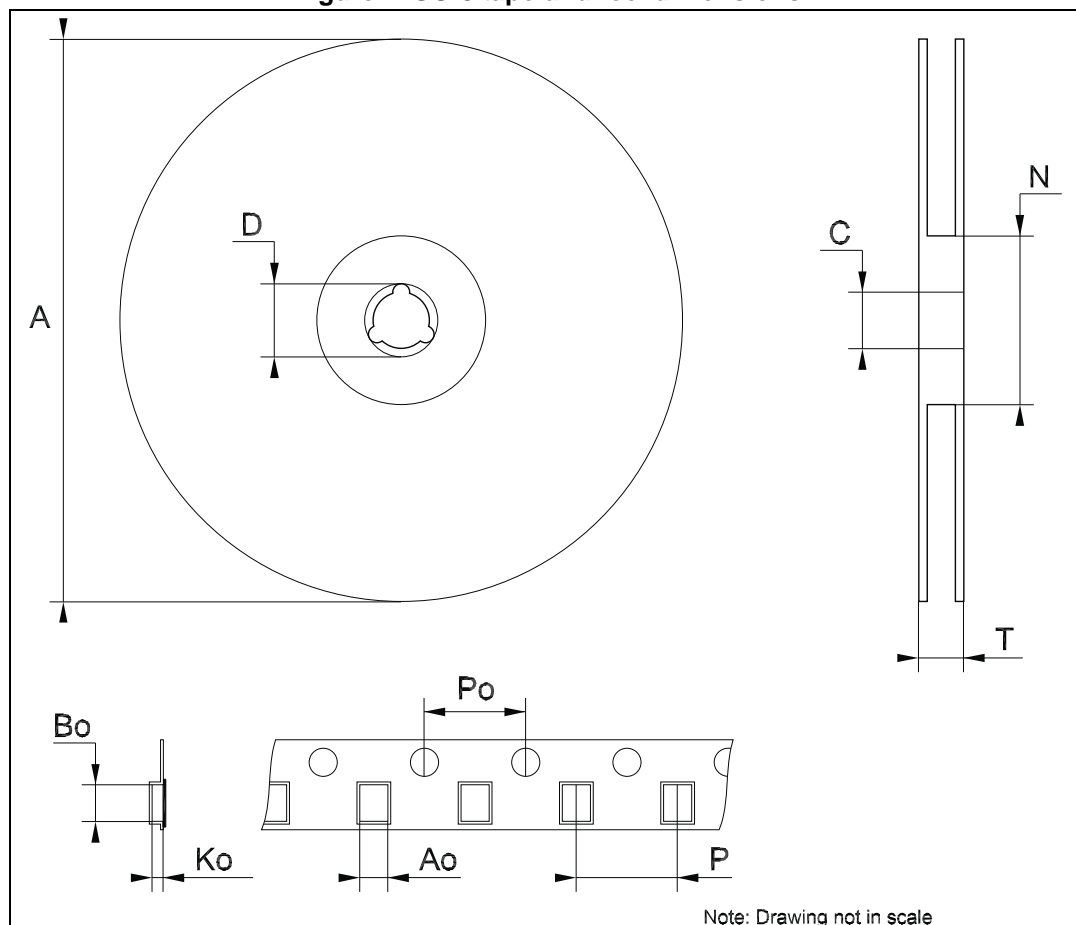


Table 9. SO-8 tape and reel mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A			330
C	12.8		13.2
D	20.2		
N	60		
T			22.4
Ao	8.1		8.5
Bo	5.5		5.9
Ko	2.1		2.3
Po	3.9		4.1
P	7.9		8.1

6 Revision history

Table 10. Revision history

Date	Revision	Changes
30-Jan-2014	1	First revision.

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